

N-Channel MOSFET

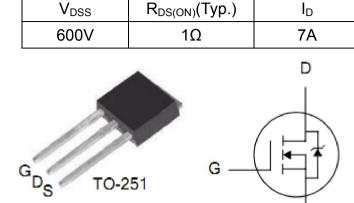
Applications:

- Adaptor
- Charger
- .SMPS

Features:

- RoHS Compliant
- Low ON Resistance
- .Low Gate Charge
- •Peak Current vs Pulse Width Curve
- Inductive Switching Curves

Ordering Information

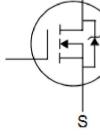


Packages Not to Scale

TO-251

Pb

 V_{DSS}



 I_{D}

PART NUMBER PACKAGE BRAND ITU07N60R TO-251 IPS

Absolute Maximum Ratings

$T_{\rm C}$ =25 °C unless otherwise specified

Symbol	Parameter	ITU07N60R	Units
V _{DSS}	Drain-to-Source Voltage	600	V
I _D	Continuous Drain Current	7	А
I _{DM}	Pulsed Drain Current, V _{GS} @10V (NOTE *2)	28	А
D	Power Dissipation	100	W
P _D	Derating Factor above 25℃	0.8	W/℃
V _{GS}	Gate-to-Source Voltage	±30	V
E _{AS}	Single Pulse Avalanche Energy (L=10mH)	400	mJ
TL	Maximum Temperature for Soldering	300	
$T_{\rm J}$ and $T_{\rm STG}$	Operating Junction and Storage Temperature Range (NOTE *1)	150,-55 to150	°C

Thermal Resistance

Symbol	Parameter	Тур.	Units	Test Conditions
P	Junction-to-Case 1.25		Water cooled heatsink, P_{D} adjusted for a	
$R_{ extsf{ heta}JC}$	Junction-to-Case	1.25	°C /W	peak junction temperature of +150℃.
R _{θJA}	Junction-to-Ambient	100		1 cubic foot chamber, free air.

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Lead Free Package and Finish



OFF Characteristics $T_C=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	600			V	V _{GS} =0V, I _D =250µA
I _{DSS}				- 1	μA	V_{DS} =600V, V_{GS} =0V
	Drain-to-Source Leakage Current					T J=25 ℃
	Drain-10-Source Leakage Current			100	μΛ	V_{DS} =480V, V_{GS} =0V
				100		T J=125 ℃
I _{GSS}	Gate-to-Source Forward Leakage			+100	20	V_{GS} =+30V
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -30V

ON Characteristics $T_J=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
R _{DS(ON)}	StaticDrain-to-Source		1	1 0	0	V _{GS} =10V, I _D =3.5A
	On-Resistance(NOTE *3)		1	1.3	Ω	
V _{GS(TH)}	Gate Threshold Voltage	2		4	V	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$
9 _{fs}	Forward Transconductance(NOTE *3)		6.5		S	V _{DS} =15V, I _D =3.5A

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
C _{iss}	Input Capacitance		1121		pF	(1 - 0)(1)(-2E)(
C _{oss}	Output Capacitance		96			V_{GS} = 0V, V_{DS} = 25V f =1.0MHz
C _{rss}	Reverse Transfer Capacitance		5.5			
Qg	Total Gate Charge		24			I _D =7A,V _{DD} =480V V _{GS} = 10V
Q _{gs}	Gate-to-Source Charge		4.8		nC	
Q_{gd}	Gate-to-Drain ("Miller") Charge		9.5			v _{GS} – 10V

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
t _{d(ON)}	Turn-on Delay Time		18			
t _{rise}	Rise Time		22			V _{DD} =300V, I _D =7A,
t _{d(OFF)}	Turn-Off Delay Time		40		ns	V_G =10V R _G =10 Ω
t _{fall}	Fall Time		19			

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Source-Drain Diode Characteristics	Tc=25
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Tc=25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
ls	Continuous Source Current			7	А	T _C =25℃
	(Body Diode)					
I _{SM}	Maximum Pulsed Current			28	А	
	(Body Diode)			20		
V_{SD}	Diode Forward Voltage			1.5	V	I _{SD} =7A, V _{GS} =0V
t _{rr}	Reverse Recovery Time		363		ns	I _F = I _S
Q _{rr}	Reverse Recovery Charge		1920		nC	di/dt=100A/us

Notes:

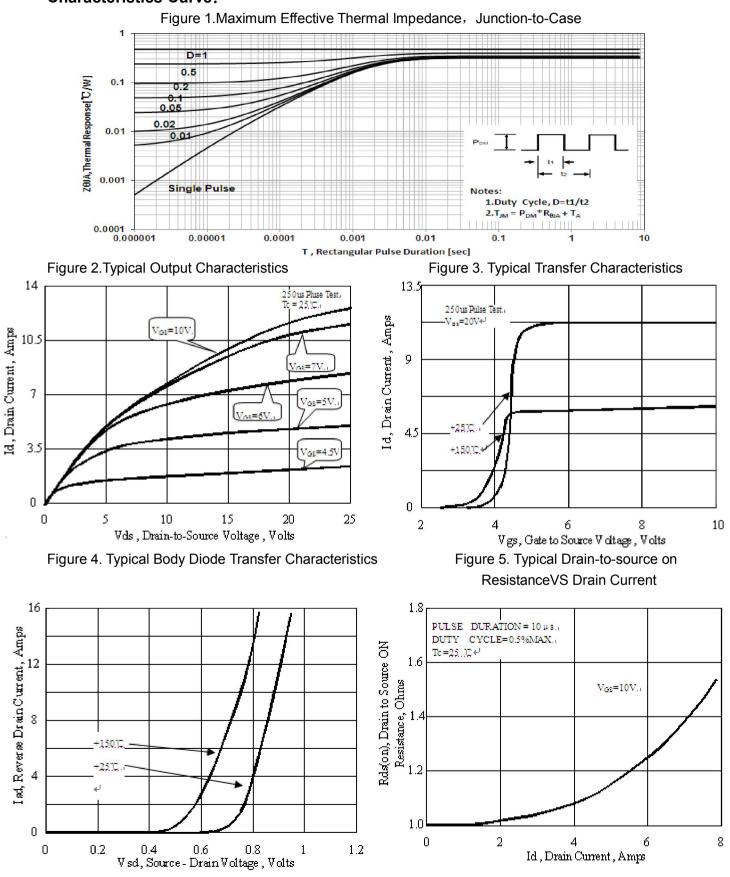
*1. T_J = +25 $^\circ \rm C$ to +150 $^\circ \rm C$.

*2. Repetitive rating; pulse width limited by maximum junction temperature.

*3. Pulse width < 380μ s; duty cycle < 2%.



Characteristics Curve:



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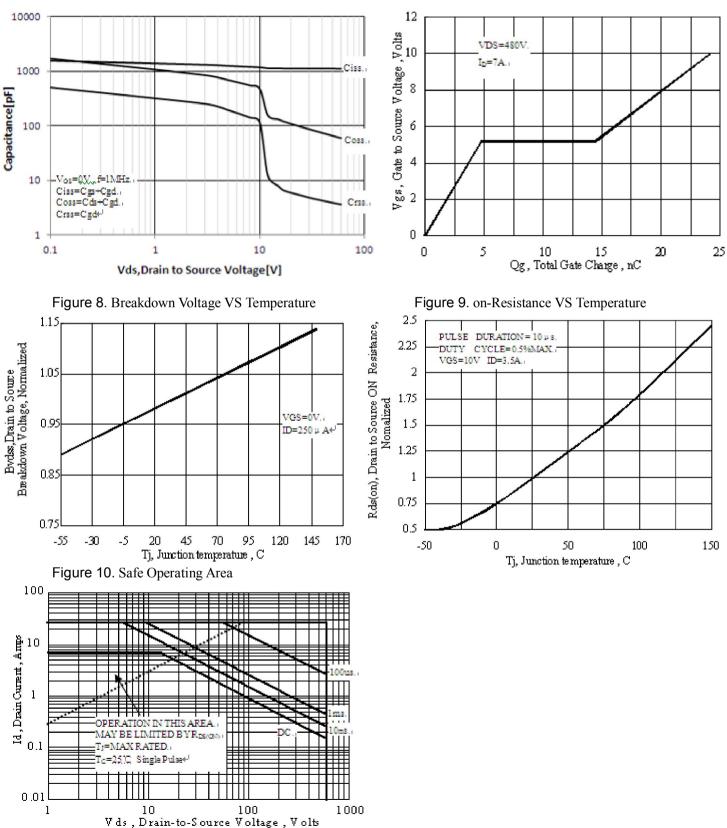


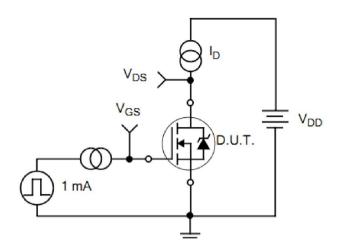
Figure 6. Capacitance VS Drain-to-Source Voltage

Figure 7. Gate Charge VS Gate-to-Source Voltage



ITU07N60R

Test Circuits and Waveforms



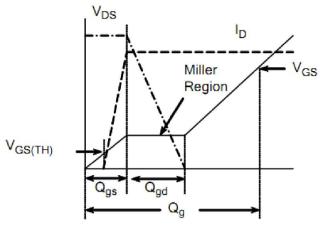
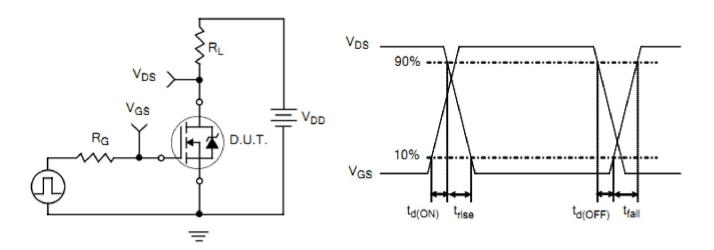


Figure 11. Gate Charge Test Circuit

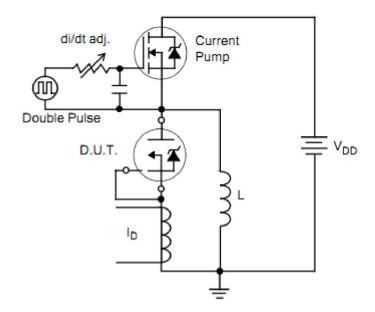
Figure 12. Gate Charge Waveforms











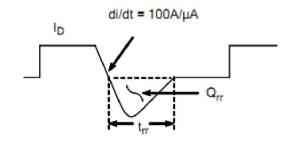


Figure 15. Diode Reverse Recovery Test Circuit

Figure 16. Diode Reverse Recovery Waveform

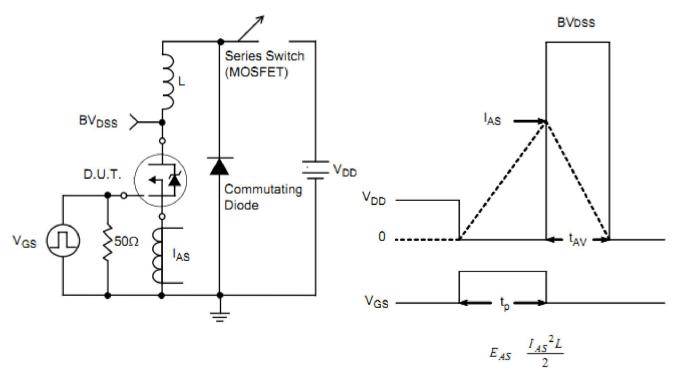


Figure 17. Unclamped Inductive Switching Test Circuit Figure 18. Unclamped Inductive Switching Waveform



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